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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)			
	10/568,949	COLE, BRYAN E.			
Office Action Summary	Examiner	Art Unit			
	Constantine Hannaher	2884			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period w. - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	lely filed the mailing date of this communication. (35 U.S.C. § 133).			
Status					
Responsive to communication(s) filed on <u>22 Fe</u> This action is FINAL . 2b)⊠ This Since this application is in condition for allowar closed in accordance with the practice under E	action is non-final. nce except for formal matters, pro				
Disposition of Claims					
4) ☐ Claim(s) 1-22 and 25 is/are pending in the appleatable (a) Of the above claim(s) is/are withdraw 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-22 and 25 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or Application Papers 9) ☐ The specification is objected to by the Examine	vn from consideration. r election requirement. r.				
10)☑ The drawing(s) filed on 22 February 2006 is/are Applicant may not request that any objection to the o Replacement drawing sheet(s) including the correcti 11)☐ The oath or declaration is objected to by the Ex	drawing(s) be held in abeyance. See ion is required if the drawing(s) is obj	e 37 CFR 1.85(a). ected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119					
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 					
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 20060222,20060313.	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:	ite			

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DETAILED ACTION

Claim Objections

1. Claim 19 objected to because of the following informalities: only "a third region" is

established by claim 18. Appropriate correction is required.

Claim Rejections - 35 USC § 112

2. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 22 and 25 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for

failing to particularly point out and distinctly claim the subject matter which applicant regards as the

invention.

3.

Claim 22 provides for the use of an apparatus, but, since the claim does not set forth any

steps involved in the method/process, it is unclear what method/process applicant is intending to

encompass. A claim is indefinite where it merely recites a use without any active, positive steps

delimiting how this use is actually practiced.

Claim 25 recites "the angular range to be expected by Snell's law for radiation to be

reflected" but since Snell's Law is one of refraction, not reflection, of radiation upon passage

between regions of different refractive index, no such range of expectation can be established.

Accordingly, the limitation which might be imposed on the positioning of the detector is not

defined.

Claim Rejections - 35 USC § 101

4. 35 U.S.C. 101 reads as follows:

Whoever invents or discovers any new and useful process, machine, manufacture, or composition of matter, or any new and useful improvement thereof, may obtain a patent therefor, subject to the conditions and requirements of

this title.

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5. Claim 22 is rejected under 35 U.S.C. 101 because the claimed recitation of a use, without setting forth any steps involved in the process, results in an improper definition of a process, i.e., results in a claim which is not a proper process claim under 35 U.S.C. 101. See for example *Exparte Dunki*, 153 USPQ 678 (Bd.App. 1967) and *Clinical Products, Ltd.* v. *Brenner*, 255 F. Supp. 131, 149 USPQ 475 (D.D.C. 1966).

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Claim Rejections - 35 USC § 102

6. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 7. Claims 1-5, 14, 16-21, and 25 are rejected under 35 U.S.C. 102(b) as being clearly anticipated by Cheo (US004197457A).

With respect to independent claim 1, Cheo discloses a method of investigating a sample 12 corresponding to the illustrated apparatus 10 (FIG. 1) which would comprise the steps of irradiating the sample with radiation 20 having at least one frequency in the recited range (column 3, lines 64-65) and detecting radiation that is scattered by the sample 12 using a detector 43 positioned relative to the sample so as to "reduce" detection of specular radiation (column 5, lines 12-16).

With respect to dependent claim 2, the method of Cheo further comprises the step of analyzing the detected radiation to determine a characteristic (presence of defect **36**) of the sample.

With respect to dependent claim 3, the radiation detected in the method of Cheo is substantially non-specular reflection (column 5, lines 17-25).

With respect to dependent claim 4, the radiation detected in the method of Cheo is backscattered radiation (column 6, lines 21-28).

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With respect to dependent claim 5, the method of Cheo further comprises the step of positioning the sample 12 so as to direct specular reflection away from one or more detectors 42, 43 detecting the non-specular radiation (in view of the vertical inclination).

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With respect to dependent claim 14, the method of Cheo further comprises the step of positioning the sample 12 so that specular reflection is directed back towards an emitter 18 configured to irradiate the sample (FIG. 1).

With respect to independent claim 16, Cheo discloses an apparatus 10 for investigating a sample 12 (FIG. 1) comprising an emitter 18 for irradiating the sample with radiation 20 having at least one frequency in the recited range (column 3, lines 64-65) and a detector 43 for detecting radiation that is scattered by the sample 12 in a non-specular manner (column 4, lines 54-58) and which is positioned relative to the sample so as to "reduce" detection of specular radiation (column 5, lines 12-16).

With respect to dependent claim 17, the detector **43** in the apparatus of Cheo is positioned so as to detect substantially non-specular reflection (column 5, lines 17-25).

With respect to dependent claims 18-20, the emitter **18** and detector **43** in the apparatus of Cheo are positioned as recited (FIG. **1**).

With respect to dependent claim 21, the apparatus of Cheo further comprises at least one additional detector 42 for detecting non-specular radiation scattered by the sample 12 (column 6, lines 44-50).

With respect to independent claim 25, Cheo discloses a method of investigating a sample 12 corresponding to the illustrated apparatus 10 (FIG. 1) which would comprise the steps of irradiating the sample with radiation 20 having at least one frequency in the recited range (column 3, lines 64-65) and detecting radiation that is scattered by the sample 12 using one or more detectors 42, 43

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positioned in a region out of the angular range to be expected for radiation to be reflected (or refracted under principles following Snell's Law) from the sample surface (column 5, lines 12-16).

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Claim Rejections - 35 USC § 103

- 8. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 9. Claims 12 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Cheo (US004197457A) in view of Nuss (US005623145A).

With respect to dependent claim 12, although Cheo appears to disclose irradiating the sample 12 along a slice (compare FIGs. 1 and 2), Nuss specifically teaches that the irradiation of a sample 4 (FIG. 4) with radiation of a frequency in the recited range (column 2, lines 53-55) at a number of points on the surface thereof is known. In view of the acquisition of information regarding a region of the sample larger than the spot diameter (column 3, lines 43-51) it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the method of Cheo to further comprise the step of irradiating the sample 12 at a number of points on the surface thereof such that more than a single slice is examined.

With respect to dependent claim 13, see the explanation of the rejection against claim 12. The raster scanning suggested by FIG. 4 of Nuss and the extended traverse of radiation 20 through the thickness of sample 12 in Cheo would result in the derivation of three dimensional distribution information characterizing the sample.

With respect to dependent claim 6, the analyzing in the method of Cheo can be presumed to obtain a time domain waveform from the radiation detected by detectors 42, 43. Arnone *et al.* teaches that in the measurement of frequencies in ranges which overlap the range taught by Cheo (see, for example, pages 3 and 4 of Arnone *et al.*) analysis by obtaining a frequency spectrum from the time domain waveform and deriving information characterizing a sample from the frequency spectrum is known (page 6). It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the method of Cheo to include the additional step of analysis by plotting the amplitude of the detection radiation originally obtained in the time domain in the frequency domain since Arnone *et al.* treats the two domains as interchangeable.

With respect to dependent claim 7, Arnone *et al.* teaches that characterizing the sample graphically is known (page 6). It would have been obvious to one of ordinary skill in the art at the time the invention was made that the spectral plotting suggested by Arnone *et al.* would, in the method of Cheo which detects scattered radiation, be a graphic characterization in a scattering spectrum.

With respect to dependent claim 8, it would have been obvious to one of ordinary skill in the art at the time the invention was made to prepare an average scattering spectrum according to the suggestion of Arnone *et al.* to reduce dependence on variations between sample regions or between samples and the like.

With respect to dependent claim 9, the information derived in the method suggested by Cheo and Arnone *et al.* characterizes an internal structure ("voids, contaminants, and flaws") of the sample 12.

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With respect to dependent claim 10, the information derived in the method suggested by Cheo and Arnone *et al.* can be presumed to characterize the granularity and/or density of the sample 12 in view of the identical steps and the different void sizes with different granularity.

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With respect to dependent claim 11, the information derived in the method suggested by Cheo and Arnone *et al.* characterizes impurities or defects ("voids, contaminants, and flaws") in the sample 12.

With respect to dependent claim 15, the method of Cheo applies to finding defects **36** such as voids, contaminants, and flaws in "any far-infrared transparent media" (column 1, lines 9-13). Arnone *et al.* teaches that a pharmaceutical sample **49** is transparent (FIG. **2**) to frequencies in ranges which overlap the range taught by Cheo (see, for example, pages 3 and 4 of Arnone *et al.*). Accordingly, it would have been obvious to one of ordinary skill in the art at the time the invention was made that a pharmaceutical sample as suggested by Arnone *et al.* was a member of the class of any far-infrared transparent media taught by Cheo and to use the disclosed method to characterize pharmaceutical samples for voids, contaminants, and flaws.

With respect to dependent claim 22, to the extent understood, see the explanation of the rejection against claim 15. The use of the apparatus of Cheo to characterize a pharmaceutical sample would have been obvious to one of ordinary skill in the art at the time the invention was made in view of the suggestion of Arnone *et al.* that a pharmaceutical sample is suitable for use as the sample 12 in the apparatus of Cheo.

Conclusion

11. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Constantine Hannaher whose telephone number is (571) 272-2437. The examiner can normally be reached on Monday-Friday with flexible hours.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David P. Porta can be reached on (571) 272-2444. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Constantine Hannaher/
Primary Examiner, Art Unit 2884